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Reaction mechanism of atomic layer deposition of zirconium oxide using tris(dimethylamino)cyclopentadienyl zirconium: experimental and theoretical study†

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We investigated the reaction mechanism of atomic layer deposition (ALD) of zirconium oxide (ZrO_2) by integrating experiments and calculations. The ALD process by alternating the supply of tris(dimethylamino)cyclopentadienyl zirconium ($CpZr(NMe_2)_3$) and ozone (O_3) was examined using an *in situ* quartz crystal microbalance (QCM) and the successive surface reaction of the Zr precursor was simulated by density functional theory (DFT) calculations. The QCM analysis suggests that two NMe₂ ligands are released during the first half-cycle of ALD. The DFT calculations indicate that the first two NMe₂ ligands are released during the chemisorption of the Zr precursor with low activation energies of 0.22 eV and 0.16 eV. Conversely, the release of the Cp ligand or the third NMe₂ ligand was unfavorable due to its endothermic nature and high activation energy. Upon completion of the chemisorption of the Zr precursor, the resulting surface species would be $O_2ZrCp(NMe_2)^*$, which is in agreement with the QCM results. The integration of the QCM experiment and the DFT calculations is an effective approach to elucidate the ALD reaction mechanism, especially when a heteroleptic precursor is used.

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Introduction

One promising approach to developing advanced precursors for atomic layer deposition (ALD) is to create heteroleptic metalorganic compounds in which two or more types of ligands are attached to a metal center. These heteroleptic ALD precursors are believed to possess advantages over homoleptic precursors, such as improved thermal stability while maintaining reactivity. A notable success was the combination of alkylamide and cyclopentadienyl ligands in a Zr compound to form tris(dimethylamino)cyclopentadienyl zirconium (CpZr(NMe₂)₃), which successfully replaced an alkylamide-based homoleptic Zr precursor, tetrakis(ethylmethylamino)zirconium (Zr(NEtMe)₄), in the fabrication of dynamic random-access memory (DRAM) devices. In comparison to a homoleptic precursor of Zr(NEtMe)₄, CpZr(NMe₂)₃ exhibits better thermal stability, resulting in better

The ALD process using CpZr(NMe₂)₃ and H₂O has been examined by *in situ* quartz crystal microbalance (QCM) at 250 °C.¹² The authors concluded that one Cp ligand per two Zr atoms remains adsorbed at the end of the precursor pulse. However, if this conclusion is correct, the Zr atoms are not sufficiently passivated by the ligands and interact with other Zr precursor molecules, which differs from the ideal ALD process in which the submonolayer grows in a self-limiting manner.

The surface reaction mechanisms of $CpZr(NMe_2)_3$ have also been investigated by density functional theory (DFT) calculations. The two successive ligand exchange reactions of $CpZr(NMe_2)_3$ with two surface OH groups were simulated using the $(OH)_2$ – $Si_{21}H_{24}$ cluster model, which mimics hydroxylated Si(100). The reactions were endothermic, making it challenging to elucidate the underlying mechanisms of film growth. In contrast, another study investigated the three successive ligand exchange reactions of $CpZr(NMe_2)_3$ with three surface OH groups using the $(OH)_4$ – $Si_{15}O_{10}H_{16}$ cluster model, which mimics hydroxylated SiO_2 . The three reactions, which successively release three $HNMe_2$ molecules, were plausible due to their exothermic nature and low activation energy values. The other study used the $(OH)_4$ – $Si_{15}H_{16}$ cluster model, which mimics the OH-terminated Si(100) surface, and also claimed

conformality at a high process temperature of 300 $^{\circ} C$ with a growth per cycle of $\sim\!0.9~\text{Å.}^{8}$

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that three ligand exchange reactions were exothermic, releasing three HNMe2 molecules. 15 Consequently, both studies conclude that CpZr(NMe₂)₃ reacts with the surface to form -ZrCp*, where the asterisk denotes the surface species. However, this conclusion does not agree with the experiment, which expected a Cp per two Zr atoms. 12 Since the models mimic OHpassivated Si or SiO2, the mechanism they studied would represent the initial stage of the ALD process. Furthermore, the studies did not consider the reactions that release the Cp ligand. No study has combined in situ characterization experiments and theoretical studies to gain a deeper understanding of the ALD process.

In this study, we investigated the surface reactions of CpZr(NMe₂)₃ precursor during the ALD of ZrO₂ by combining in situ QCM experiments and DFT calculations. First, in situ QCM analysis was conducted to examine the surface species after the precursor dose. O₃ was selected as the oxygen source due to shorter purge times than H₂O¹⁶ and better step coverage than O2 plasma. 17 Next, DFT calculations were performed to investigate the surface reactions of CpZr(NMe₂)₃ on ZrO₂. The ZrO₂ slab model previously employed in the DFT study using Zr(NMe₂)₄¹⁸ was also utilized in the present study. The adsorption, reaction, and activation energies were calculated for the three successive surface reactions of CpZr(NMe₂)₃ with ZrO₂. Furthermore, the atomistic geometries of the transition states were investigated and discussed. Finally, based on the results from the in situ QCM and DFT studies, the final chemisorbed species was predicted and compared with the results for $Zr(NMe_2)_4$ in the previous study.

Materials and methods

Experimental methods

ZrO₂ films were grown using a hot-wall ALD reactor (iOV-fX2, ISAC Research Co. Ltd., Republic of Korea), and the film growth was monitored in real-time using a QCM system (SQM-160, INFICON, Switzerland) with a GaPO₄ crystal resonator (R-30, Piezocrystal, Germany). The principles of in situ QCM measurements were initially established by Rocklein et al. 19 and Sauerbrey et al.20 Further details regarding the methods and conditions were described in another publication.²¹ The canister containing CpZr(NMe2)3 (Hansol Chemical Co. Ltd., Republic of Korea) was maintained at 50 °C, and the precursor vapor was supplied in conjunction with Ar carrier gas (100 sccm). An ozone-oxygen mixture generated by an ozone generator (LAB-II, Ozonetech Co., Republic of Korea) was used as a co-reactant. The pulse times of CpZr(NMe₂)₃ and O₃ were 7 s and 60 s, respectively. Ar gas served as the purge gas between precursor and reactant pulses. The process pressure was 1 torr. The average $\Delta f_0/\Delta f_1$ ratio was obtained from the examination during 17 ALD cycles.

Computational methods

The Dmol³ module in Material Studio 7.0 (BIOVIA, USA)^{22,23} was utilized for DFT calculations. The generalized gradient approximation and the Perdew-Burke-Ernzerhof exchange-correlation

functional²⁴ were employed with a numerical basis set of double numerical polarization 4.4. The core electrons of Zr atoms were treated with the DFT semi-core potential,²⁵ and the DFT-D2 dispersion correction density functional was applied.^{26,27} The electron configurations for Zr, O, N, C, and H elements are as follows: Zr [Kr] 5s2 4d2, O [He] 2s2 2p4, N [He] 2s2 2p3, C [He] 2s2 2p2, and H 1s1. The effective core treatment was employed for Zr only. The convergence threshold and the thermal smearing were 1×10^{-5} Ha and 9×10^{-4} Ha, respectively. The Monkhorst-Pack scheme was implemented with a K-point grid sampling of $2 \times 2 \times 1$ for the irreducible Brillouin zone. The convergence tolerance parameters for geometry optimization included a maximum displacement of 0.005 Å, a total energy change of 10^{-5} Ha, and an atomic force of 2×10^{-3} Ha Å⁻¹. The complete linearquadratic synchronous transit (LST-QST) or QST method was employed to determine the transition state²⁸ with a root mean square (RMS) atomic force threshold of 0.002 Ha \mathring{A}^{-1} . The details of the transition state search method have been previously discussed in another publication.29

The substrate model that was previously used in our research was also employed in this study. 18 Fig. 1 shows a 2×2 supercell slab model of monoclinic ZrO2 (-111). The slab consists of 32 Zr, 72 O, and 16 H atoms. The top and bottom layers were passivated with eight OH groups, resulting in a surface OH density of 4.5 nm⁻². The bottom half was fixed, while the top half was relaxed for all DFT calculations.

For each reaction path, the reactant (R), product (P), and transition states (TS) were established. Additionally, the unbound reactant (UR) state, representing a system devoid of interaction between the precursor molecule and the substrate, was considered for the initial step of the chemisorption process. The energy of the UR state was calculated as the sum of the substrate energy ($E_{\text{substrate}}$) and the isolated precursor energy ($E_{\text{precursor}}$). The **R1** state represents the physisorption of the Zr precursor, whereas R2 and R3 are the states where the first and second byproducts are removed, respectively.

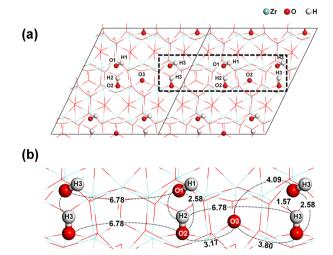


Fig. 1 Schematic illustration of (a) the monoclinic ZrO₂ (-111) slab model and (b) the reaction sites considered for the chemisorption of Zr precursor. Interatomic distances are given in Å

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The product states with one, two, and three Zr-O bonds are P1, P2, and P3, respectively. TS1, TS2, and TS3 are transition states. The physisorption energy (E_{phy}) , reaction energy (ΔE_n) , and activation energy (E_{An}) were defined as follows:

$$E_{\text{phy}} = E_{\mathbf{R1}} - (E_{\text{substrate}} + E_{\text{precursor}})$$
 (1)

$$\Delta E_n = E_{\mathbf{P}n} - E_{\mathbf{R}n} \tag{2}$$

$$E_{\mathbf{A}n} = E_{\mathbf{TS}n} - E_{\mathbf{R}n} \tag{3}$$

where E_{Rn} , E_{Pn} , and E_{TSn} are the system energies of **R**, **P**, and **TS** of the *n*th ligand release reaction.

The bond dissociation energy (BDE) was calculated using the same methodology employed in our previous publication. 18 The ZrO₂ slab was used to calculate the BDE of Zr-O and O-H, while the Zr precursor molecule was used for calculating the BDE of Zr-N.

Results and discussion

QCM analysis

To investigate the reaction mechanism at temperatures representative of a genuine ALD process, we examined the temperature at which the precursor thermal decomposition is not observed. Fig. 2 shows the resonance frequency change when only the CpZr(NMe₂)₃ pulse and Ar purge are repeated in the temperature range of 230 °C to 330 °C without O₃ supply. At 230 °C, the frequency showed a decrease during the initial cycles due to precursor chemisorption but remained nearly constant during the subsequent cycles. This suggests the selflimiting chemisorption of the precursor. Conversely, at 250 °C and above, the frequency continued to decrease with the number of cycles, indicating the mass increase due to thermal decomposition of the precursor. Therefore, the ALD process temperature was determined to be 230 °C for the QCM analysis of this work.

Fig. 3 shows the typical change in QCM resonance frequency that occurs by alternating the supply of $CpZr(NMe_2)_3$ and O_3 . The frequency change during one ALD cycle was 4.2 Hz, which corresponds to the GPC of 0.55 Å, assuming the film density of

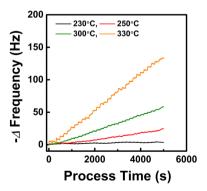


Fig. 2 Resonance frequency change resulting from repeated CpZr(NMe₂)₃ pulses and Ar purges in the absence of the O₃ supply. Process temperature was varied to identify the onset of the thermal decomposition of the precursor.

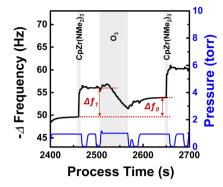


Fig. 3 Change in resonance frequency throughout the ZrO₂ ALD process at 230 °C. CpZr(NMe₂)₃ and O₃ were alternatingly supplied with pulse times of 7 s and 60 s, respectively.

4.86 g cm⁻³.30 The resonance frequency decrease observed during the CpZr(NMe₂)₃ pulse is primarily attributed to a mass increase by precursor chemisorption. In contrast, the frequency increase during the O₃ pulse is due to a mass decrease by the combustion reaction, which forms an oxide film. Δf_1 denotes the frequency change observed during the precursor pulse, while Δf_0 represents the frequency change observed throughout a complete cycle. The $\Delta f_0/\Delta f_1$ values exhibited a nearly constant ratio of 0.64 ± 0.03 .

For the first half-cycle of the ALD process, the reactions of the Cp and NMe2 ligands of CpZr(NMe2)3 with the hydroxyl groups on ZrO2 were assumed to occur, resulting in the release of HCp and HNMe2, respectively. The reaction equation is as follows:

$$(x + y)$$
-OH_(s)* + CpZr(NMe₂)_{3(g)}
 $\rightarrow (-O-)_{(x+y)}$ Cp_{1-x}Zr(NMe₂)_{3-y(s)}* + xHCp_(g) + yHNMe_{2(g)}

where the variables x and y represent the number of Cp and NMe₂ released, respectively. Subsequently, the $\Delta f_0/\Delta f_1$ ratios for all potential integer values of x and y were estimated by eqn (5) in accordance with the methodology proposed by Matero et al.31

$$\frac{\Delta f_0}{\Delta f_1} = \frac{m_0}{m_1} = \frac{M(\text{ZrO}_2)}{M[\text{CpZr}(\text{NMe}_2)_3] - xM(\text{HCp}) - yM(\text{HNMe}_2)}$$
(5)

where m_0 and m_1 denote the mass changes observed throughout a complete cycle and during the precursor pulse, respectively. M represents the molecular weight (g mol^{-1}). The estimated $\Delta f_0/\Delta f_1$ ratio most closely approximating 0.64 was 0.67 with x and y of 0 and 2, respectively, as shown in Table 1. Therefore, it can be suggested that CpZr(NMe₂)₃ underwent a reaction with the surface, resulting in the release of two HNMe2 molecules, forming -O₂ZrCp(NMe₂)*.

DFT calculations

DFT simulations were conducted to investigate the surface reactions of CpZr(NMe₂)₃ on zirconium oxide. The simulation involved three successive ligand exchange reactions between Paper

Table 1 The $\Delta f_0/\Delta f_1$ ratios estimated by eqn (5) for all potential integer combinations of the number of Cp and NMe2 ligands released from a CpZr(NMe₂)₃ molecule during the first half-cycle of ZrO₂ ALD

Number of Cp released (x)	Number of NMe_2 released (y)	Estimated $\Delta f_0/\Delta f_1$
0	0	0.46
0	1	0.54
0	2	0.67
0	3	0.86
1	0	0.59
1	1	0.75
1	2	1.00
1	3	1.52

Cp or NMe₂ of CpZr(NMe₂)₃ and the surface hydroxyl groups of ZrO₂. Since CpZr(NMe₂)₃ is a heteroleptic compound, three different initial orientations of the CpZr(NMe₂)₃ molecule were considered. In addition, two distinct paths for the release of HNMe₂ or HCp as byproducts were considered for each step of the surface reactions. These are illustrated in Fig. 4. Pna and **Pnb** represent the product states after the nth surface reaction, releasing HNMe2 or HCp, respectively. Rn represents the reactant state for the nth reaction. In R1a, one Cp and two NMe2 ligands face the substrate, while in R1\beta, three NMe2 ligands face the substrate. In R17, only the Cp ligand faces the substrate. R2 and R3 were prepared by removing HNMe₂ from P1a and P2a, respectively. Upon the removal of HCp, P1b and P2b become identical to R2 and R3 in our previous publication with Zr(NMe₂)₄. ¹⁸ Consequently, the subsequent surface reactions from P1b and P2b are repetitions of the previous publication and were not considered in this paper.

Fig. 5 shows the energy diagrams of the first ligand exchange reaction of CpZr(NMe₂)₃, from UR to P1a or P1b via R1α, R1β, or R1 γ . The adsorption energies of CpZr(NMe₂)₃ were -1.31 eV, -1.11 eV, and -1.07 eV for $R1\alpha$, $R1\beta$, and $R1\gamma$, respectively, indicating that the precursor would adsorb well on ZrO₂. The reaction from R1 to P1a, releasing HNMe2, was exothermic, with the reaction energy, ΔE_{1a} , of -0.62 eV to -0.86 eV.

The E_{A1a} values, representing the activation energy for three reaction paths from R1 to P1a, were relatively low at 0.22 eV in TS1αa, 0.19 eV in TS1βa, and 0.94 eV in TS1γa. TS1αa, TS1βa, and TS1γa represent the transition states between R1α, R1β, and R1 and P1a. However, the reaction from R1 to P1b, which releases HCp, was endothermic, with ΔE_{1b} values of 0.10–0.34 eV. The E_{A1b} of the paths from **R1** to **P1b** ranged from 1.66 eV to 3.98 eV. The change in entropy is relatively small because the reaction byproduct remains on the surface. Therefore, P1a paths are favored over P1b paths due to low activation energies. These results also indicate that the activation energies can vary depending on the initial orientation of the CpZr(NMe₂)₃ molecule.

The energy diagram for the three successive ligand exchange reactions of CpZr(NMe₂)₃ on the ZrO₂ surface is illustrated in Fig. 6. For the first reaction, the paths from the $\mathbf{R}\mathbf{1}\alpha$ shown in Fig. 5 were employed in Fig. 6 due to the lowest energy values. For all reactions, the pathways releasing HCp were endothermic and exhibited higher E_A values than those releasing HNMe₂. It can, therefore, be postulated that the surface reactions proceed through the HNMe2-releasing pathways. The desorption processes of HNMe2 from the product states in Fig. 6 were endothermic. However, P1, P2, or P3 would be transformed into R2, R3, and UP at ALD process temperatures because the desorption processes were spontaneous due to the entropy increase at temperatures above 0 °C in the previous study.18

Fig. 7 presents the atomistic structural changes during the reaction from R1 to P1. The following equations can describe the two paths for this reaction:

$$-OH^* + CpZr(NMe_2)_3 \rightarrow -OZrCp(NMe_2)_2^* + HNMe_2$$
 (6)

$$-OH^* + CpZr(NMe_2)_3 \rightarrow -OZr(NMe_2)_3^* + HCp \qquad (7)$$

The formation of P1a by eqn (6) was exothermic due to the bond formation of Zr-O1 (5.72 eV) and N-H (3.97 eV), despite the bond dissociation of Zr-N (3.64 eV) and O1-H1 (5.13 eV). 18,32 In contrast, the formation of P1b by eqn (7) was

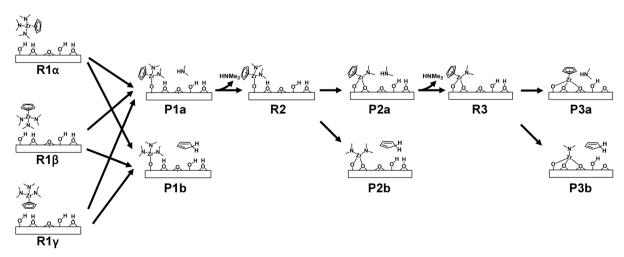


Fig. 4 Schematic of the multiple paths of surface reactions of CpZr(NMe₂)₃ on the ZrO₂ substrate.

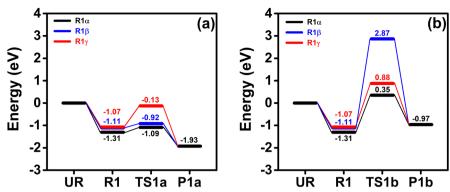


Fig. 5 Energy diagrams for the first reaction of CpZr(NMe₂)₃ from three reactant states, R1α, R1β, and R1γ, to two product states, (a) P1a and (b) P1b.

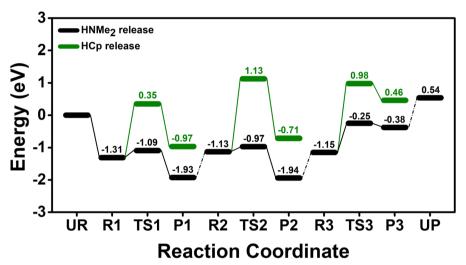


Fig. 6 Energy diagrams for the surface reactions of $CpZr(NMe_2)_3$ on ZrO_2 . The **Pna** states are the product states resulting from the *n*th surface reaction with the release of $HNMe_2$, while the **Pnb** states are the product states arising from the release of HCp.

endothermic. In comparison to eqn (6), the Zr–Cp bond (4.29 eV), which is stronger than the Zr–N bond, was dissociated, while the H–Cp bond (3.56 eV), which is weaker than the N–H bond, was newly formed in eqn (7).

In the paths leading to the formation of P1a, the N1-H1 bond was formed without dissociation of any bond in all TS1a states. This resulted in relatively low activation energy values, as shown in Fig. 5, although the Zr-N1 bond was extended. Since the Zr-N1 bond was the shortest at 2.27 Å in TS1αa, the activation energy of the path from $R1\alpha$ was the lowest at 0.22 eV. In contrast, the paths leading to the formation of P1b involve the dissociation of the Cp-Zr bond or the loss of aromaticity of Cp in TS1b states, resulting in relatively high activation energies, as shown in Fig. 5. In TS1αb, the H1 atom was dissociated from O to migrate to Cp and form the H1-Cp bond, which resulted in the loss of aromaticity. The $Zr-\eta^{-1}$ -CpH bond in **TS1** α **b** is considerably weaker than the Zr- η^5 -Cp bond in the $R1\alpha$ states, resulting in an activation energy of 1.66 eV, despite the formation of the Zr-O1 bond. In TS1βb and TS1γb, higher activation energies of 3.98 and 1.95 eV were obtained

due to the dissociation of the Cp–Zr bond despite the formation of the Zr–O1 or H1–Cp bond.

Fig. 8 shows the atomistic structural changes for the reaction from **R2** to **P2**. The following equations describe the two paths for this reaction:

$$-OH^* + -OZrCp(NMe_2)_2^* \rightarrow -O_2ZrCp(NMe_2)^* + HNMe_2$$
 (8)

$$-OH^* + -OZrCp(NMe_2)_2^* \rightarrow -O_2Zr(NMe_2)_2^* + HCp$$
 (9)

The formation of **P2a** by eqn (8) was exothermic, while the formation of **P2b** by eqn (9) was endothermic. The exothermicity or endothermicity of eqn (8) and (9) are comparable to eqn (6) and (7) because the dissociated or formed bonds are the same in both cases.

The atomistic structure of **TS2a** was analogous to that of **TS1a**, with the N2-H2 bond formed and the Zr-N2 bond elongated from 2.09 Å to 2.22 Å, resulting in a low activation energy of 0.16 eV. **TS2b**, similar to **TS1ab**, also lost the aromaticity of Cp resulting from the migration of H2 to Cp. However,

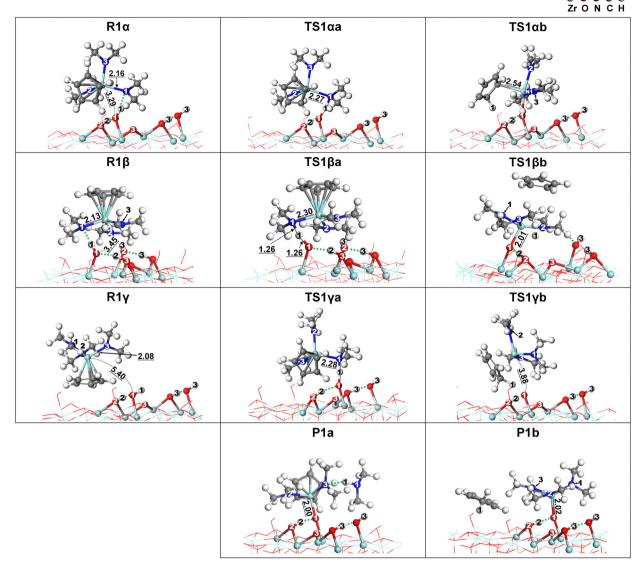


Fig. 7 The atomistic structural changes for the paths from three reactant states, R1α, R1β, and R1γ, to two product states, P1a and P1b. The dotted lines indicate hydrogen bonds. Bond lengths are given in Å.

it showed a relatively high activation energy of 2.26 eV because the Zr-O2 bond was not yet formed.

Fig. 9 shows the atomistic structural changes that occur during the reaction from R3 to P3. Two paths were also assumed as follows:

$$-OH^* + -O_2ZrCp(NMe_2)^* \rightarrow -O_3ZrCp^* + HNMe_2 \quad (10)$$

$$-OH^* + -O_2ZrCp(NMe_2)^* \rightarrow -O_3Zr(NMe_2)^* + HCp \quad (11)$$

In R3, the surface chemical species O₂ZrCp(NMe₂)* has Cp and NMe₂ in opposite directions around the Zr atom, as shown in Fig. 9. In contrast to the reactions to P1 or P2, both paths to P3 were endothermic, with ΔE_{3a} of 0.77 eV and ΔE_{3b} of 1.61 eV. The cleavage of the subsurface O3-Zr bond of both P3a and P3b in Fig. 9 can explain the observed endothermicity.

The activation energy for the path represented by eqn (10), which releases HNMe₂, was 0.90 eV, which is higher than those of eqn (6) and (8) in the reactions to P1 and P2. In TS3a, the Zr-O3 and Zr-N3 bonds were elongated, and H3b migrated from -OH3b* to the neighboring -OH3a* to form -OH2*. The activation energy for eqn (11), which releases HCp, was 2.13 eV. In TS3b, the Zr-Cp bond was dissociated, and H3b migrated from -OH3b* to form HCp. The Zr-O3 bond has not yet been formed. Consequently, the reaction to P3 would be energetically unfavorable in contrast to the reactions to P1 and P2.

The above DFT calculations predict that CpZr(NMe₂)₃ reacts with ZrO₂ to form O₂ZrCp(NMe₂)* surface species, which agrees with the results of the QCM analysis. The surface reaction of CpZr(NMe₂)₃ is expected to proceed along paths that release two HNMe₂ molecules one at a time, while the release of HCp is expected to be unfavorable. Therefore, the surface reactions of

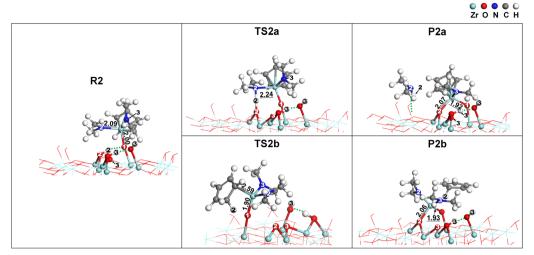


Fig. 8 The atomistic structural changes for the paths from R2 to two product states, P2a and P2b. The dotted lines indicate hydrogen bonds. Bond lengths are given in Å.

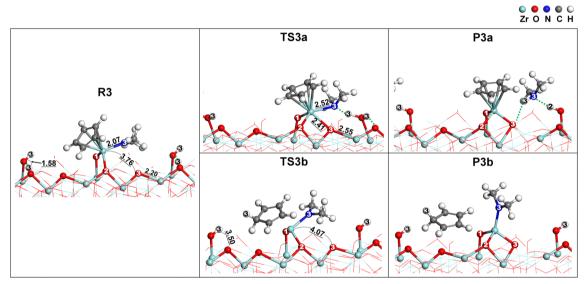


Fig. 9 The atomistic structural changes for the paths from R3 to two product states, P3a and P3b. The dotted lines indicate hydrogen bonds. Bond lengths are given in Å.

Table 2 Comparison of surface reactions of CpZr(NMe $_2$) $_3$ and Zr(NMe $_2$) $_4$

	Energy		CpZr(NMe ₂) ₃ (this study)	
Reaction step	(eV)	$Zr(NMe_2)_4^{18}$	HNMe ₂ release	HCp release
Physisorption	$E_{ m ads}$	-1.16	-1.31	-1.31
1st reaction	ΔE_1	-0.68	-0.62	0.34
	$E_{\mathbf{A}1}$	0.19	0.22	1.66
2nd reaction	ΔE_2	-1.06	-0.81	0.42
	$E_{\rm A2}$	0.24	0.16	2.26
3rd reaction	ΔE_3	0.64	0.77	1.61
	E_{A3}	0.75	0.90	2.13

 $CpZr(NMe_2)_3$, a heteroleptic precursor, were similar to those of $Zr(NMe_2)_4$, a homoleptic precursor reported in our previous publication.¹⁸ Table 2 compares the calculated energy values for the surface reaction of $Zr(NMe_2)_4$ and $CpZr(NMe_2)_3$. For the

HNMe₂ releasing paths, CpZr(NMe₂)₃ exhibited similar reaction and activation energy values to those of Zr(NMe₂)₄. The slight difference in energy values can be explained by the difference in BDE in the two compounds. For example, the $E_{\rm A2}$ of 0.16 eV for CpZr(NMe₂)₃ is lower than 0.24 eV for Zr(NMe₂)₄ due to the lower BDE of the Zr–N bond in CpZr(NMe₂)₃ compared to that in Zr(NMe₂)₄. The strong Cp–Zr bond results in a BDE of the Zr–N bond of 3.64 eV in CpZr(NMe₂)₃, which is lower than the BDE of 3.74 eV for Zr(NMe₂)₄.

Conclusions

The reaction mechanism of ALD ZrO₂ using CpZr(NMe₂)₃ was investigated through the use of *in situ* QCM and DFT. The QCM

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analysis yielded a $\Delta f_0/\Delta f_1$ ratio of 0.64 \pm 0.03 at 230 °C, indicating that one Cp ligand and one NMe2 ligand remained on the surface per CpZr(NMe2)3 molecule. A DFT calculation was conducted to simulate the successive ligand exchange reactions between CpZr(NMe2)3 and -OH terminated ZrO2. The paths releasing the first two NMe₂ ligands were exothermic, with low activation energy values of 0.22 eV and 0.16 eV. In contrast, the release of the third NMe2 ligand was endothermic and exhibited a high activation energy of 0.90 eV. The paths releasing the Cp ligand were all endothermic and exhibited high activation energies of 1.66-2.26 eV. Consequently, the resulting surface species would be O₂ZrCp(NMe₂)*, which is consistent with the OCM analysis.

Author contributions

H.-L. Kim: conceptualization, data curation, formal analysis, methodology, project administration, validation, visualization, writing - original draft. O. Kim: data curation, formal analysis, investigation, methodology, validation, visualization, writing original draft. Yong Richard Sriwijaya: formal analysis, investigation, methodology, visualization. Khabib Khumaini: validation, writing - review & editing. Romel Hidayat: conceptualization, methodology, writing - review & editing. Won-Jun Lee: conceptualization, funding acquisition, project administration, resources, supervision, validation, writing - review & editing.

Data availability

The data supporting this article have been included in the ESI.†

Conflicts of interest

There are no conflicts to declare.

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